



Application/Control No.	Applicant(s)/Patent under Reexamination
09/936,366	ROON, MARK VAN
Examiner	Art Unit
Susan V Chen	2161

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
707	104.1	5/19/2006	TYC	
707	101	5/19/2006	TYC	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated test search on West DB for classes/subclasses: 707/104.1, 707/101; 705/1	5/19/2006	TYÇ
STIC NPL search Dialog, IEEE, Inspec, etc.	5/19/2006	TYC
interference history search attached	5/19/2006	TYC